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Miner, P.S.; Malekpour, M.; Torres, W.;

Digital Avionics Systems Conference, 2002. Proceedings. The 21st , Volume: 2 , 2002

Pages:13D3-1 - 13D3-11 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(872 KB\)\]](#) **IEEE CNF**

2 Optically amplified TDMA distributive switch network with 2.488 Gb capacity offering interconnection to over 1000 customers at 2 Mbit/s

Culverhouse, S.; Lobbett, R.A.; Smith, P.J.;

Electronics Letters , Volume: 28 , Issue: 17 , 13 Aug. 1992

Pages:1672 - 1673

[\[Abstract\]](#) [\[PDF Full-Text \(168 KB\)\]](#) **IEEE JNL**

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